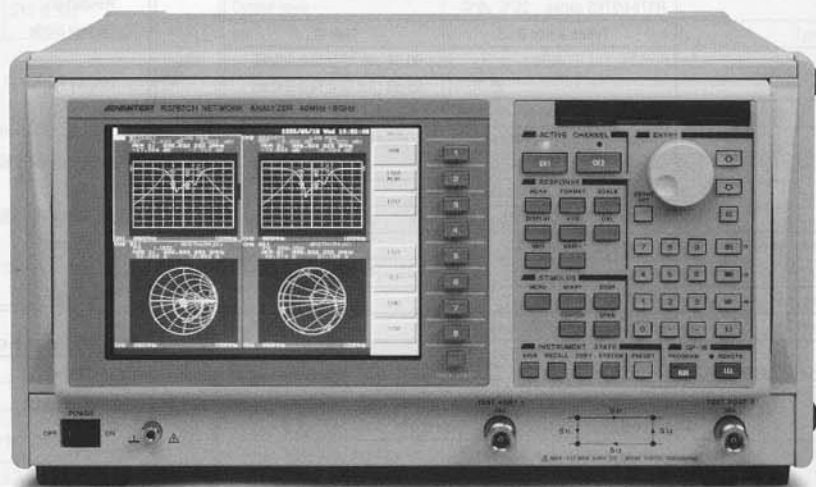


# Network Analyzers

For Evaluation and Inspection of Digital Communication Devices

## R3766H/3767H Series

- Measurement frequency range  
40MHz to 8.0GHz R3766H/3767H Series
- Three models available for all types of applications  
Type A: Basic Model  
Type B: Built In SWR Bridge Model  
Type C: Built In S-parameter Test Set Model
- High sweep speed  
0.15ms/point(with normalized calibration)  
0.25ms/point(with 2-port full calibration)
- 4-channel, 8-trace high-performance display
- 100 dB dynamic range measurement



(Photo is R3767CH)

## R3766H/3767H series Network Analyzers

Recent years have seen a great progress in digital information and communication equipment such as PDC/PHS digital mobile radio equipment and communication equipment for ISDN. Accordingly, requirements for dielectric filters, SAW filters, layer-built filters, antennas, isolators, power amplifiers, and other high-frequency electronic devices used in communication equipment are becoming more severe and stricter: higher frequency, smaller sizes, lower power consumption, and so on. The R3766H/3767H series is a vector network analyzers which can measure the amplitude, phase, group delay time and impedance of high-frequency electronic devices with high precision and high speed.

The series comes in three different models with measurement frequency ranges: 40MHz to 8.0GHz.

In addition, the use of newly developed high-speed signal processing architecture realizes high speed measurement of 0.15ms/point (at normalized calibration) or 0.25ms/point (at 2-port full calibration) with 10 kHz resolution bandwidth.

One of the major advantages of the series is that it helps you choose the model which best suits your application.

The R3766H/3767H using a 7.8-inch large TFT color LCD is suitable both for line and engineering use. Each series comes in three different models including type A (basic model), type B (model with a built-in SWR bridge) and type C (model with a built-in S-parameter test set).

### ■ Programmed Sweep Realizes High-Speed and High-Resolution Measurement

The R3764H/3765H/3766H/3767H series is provided with the programmed sweep function as standard which makes it possible to vary output power and resolution bandwidth (RBW) during sweep.

In evaluation of filter characteristics for instance, measurement with high speed, high accuracy and high reproducibility can be realized by varying resolution bandwidth and output power in pass or stop band.

### ■ Limit Line Function for Adjustment and Test

The limit line function performs PASS/FAIL test based on the judgment value set by the limit line editor and then displays the test result. In addition, the color of limit lines

and waveform data can be specified for each judgment area, allowing the user to make PASS/FAIL judgment at a glance during judgement on the screen.

In POLAR and Smith chart measurement, the series has the ability to make limit judgement both for amplitude/phase adjustment for specified frequency ranges and automatic test result judgement.

### ■ Improved H Series Performance Items

- Manually selectable display colors (256 colors)
- Expanded BASIC programming memory capacity (1MB)
- Expanded save register capacity (2MB)
- Improved BASIC processing speed
- CDMA IF filter analysis function integrated
- New 3-port device calibration function

# Network Analyzers

For Evaluation and Inspection of Digital Communication Devices

## R3766H/3767H Series

### Specifications

#### Measurement Functions

Sweep channel	2 channel (CH 1 and CH 2)		
Display channel	4 channel (CH 1, and CH 2, CH 3, and CH 4)		
Trace	2 traces/channel		
Display parameter	<b>TypeA</b>	<b>TypeB</b>	<b>TypeC</b>
	A/R, B/R	Transmission Reflection Transmission& reflection	S11, S21, S22, S12 S21&S11, S12&S22
Format	Log/linear amplitude, phase, and group delay or real part + imaginary part of complex parameter [Z], R, X (at measurement with impedance conversion) [Y], G, B (at measurement with admittance conversion) Phase extension display function		
Rectangular coordinates	Log/linear amplitude, phase, and group delay or real part + imaginary part of complex parameter [Z], R, X (at measurement with impedance conversion) [Y], G, B (at measurement with admittance conversion) Phase extension display function		
Smith chart (R3767H only)	Maker reading: Log/linear amplitude, phase, real part + imaginary part, R + jX, G + jB		
Polar coordinates (R3767H only)	Maker reading: Log/linear amplitude, phase, real part + imaginary part		

#### Receiver Characteristics

Resolution bandwidth	10 kHz to 10 Hz (in 1 or 3 steps)	
Amplitude characteristics	0.001 dB	
Amplitude resolution	With respect to -20 dB below maximum input level of test port	
Dynamic accuracy	0 to -10 dB	
	±0.3 dB (40 MHz ≤ f ≤ 3.8 GHz)	±0.8 dB (3.8 MHz ≤ f ≤ 8.0 GHz)
	±0.05 dB (40 MHz ≤ f ≤ 3.8 GHz)	±0.2 dB (3.8 MHz ≤ f ≤ 8.0 GHz)
	-10 to -20 dB	±0.05 dB
	-20 to -50 dB	±0.10 dB
	-50 to -60 dB	±0.15 dB
	-60 to -70 dB	±0.40 dB
	-70 to -80 dB	±1.00 dB
	-80 to 90 dB	±1.00 dB
Frequency characteristics	1.0 dB (-10 dBm, 25°C ±5°C)	
Phase characteristics	±180° (Display for ±180° or more is possible by means of display extension function)	
Measurement range	0.01°	
Phase resolution	±5° (-10 dBm, 25°C ±5°C)	
Frequency characteristics	With respect to -20 dB below maximum input level of test port	
Dynamic accuracy	0 to -10 dB	
	±5.0°	±0.3° (40 MHz ≤ f ≤ 3.8 GHz)
	±0.3° (40 MHz ≤ f ≤ 3.8 GHz)	±0.8° (3.8 GHz ≤ f ≤ 8.0 GHz)
	-10 to -20 dB	±0.3°
	-20 to -50 dB	±0.4° (40 MHz ≤ f ≤ 3.8 GHz)
	-50 to 60 dB	±0.8° (3.8 GHz ≤ f ≤ 8.0 GHz)
	-60 to -70 dB	±1.5°
	-70 to -80 dB	±4.0°
	-80 to 90 dB	±8.0°
Group delay time characteristics	Calculated by the following expression:	
Range	$r = \frac{\Delta \theta}{360 \times \Delta f}$ Δθ: Phase Δf: Aperture frequency (Hz)	
Measurement range	1 ps to 250 s	
Group delay time resolution	1 ps	
Aperture frequency	Is equal to Δf and can be set to A × 2% to A × 100% for frequency span, with a resolution of A × 2%.	
	$A = \frac{100}{\text{measurement points} - 1}$ Phase accuracy	
Accuracy	360 × Aperture frequency (Hz)	

#### Signal Source Characteristics

Measurement frequency	40MHz to 8.0 GHz		
Range	40MHz to 8.0 GHz		
Set resolution	1 Hz		
Measurement resolution	±0.005 ppm		
Accuracy	±20 ppm (25°C ±5°C)		
Stability	±5 ppm (25°C ±5°C)		
Output level (40 MHz to 3.8 GHz)	<b>Type A</b>	<b>Type B</b>	<b>Type C</b>
Range	+17 to -8 dBm	+7 to -18 dBm	+10 to -15 dBm
Resolution	0.01 dB		
Accuracy	±0.5 dB (50 MHz, 0dBm, 25°C ±5°C)		
Linearity	25°C ±5°C		
Type A	±0.4 dB	+12 to -3 dBm	With respect to +7 dBm
	±0.7 dB	+17 to -8 dBm	to +7 dBm
	±0.4 dB	+2 to -13 dBm	With respect to -3 dBm
Type B	±0.7 dB	+7 to -18 dBm	to -3 dBm
	±0.4 dB	+5 to -10 dBm	With respect to 0 dBm
Type C	±0.7 dB	+10 to -15 dBm	to 0 dBm
	±0.4 dB	+10 to -15 dBm	to 0 dBm
Flatness	2.0 dBp-p (25°C ±5°C) For type C, at test port		
Output level (3.8 GHz to 8GHz)	Output level fixed		
	<b>Type A</b>	<b>Type B</b>	<b>Type C</b>
	-3 dBm or more	-16 dBm or more	-13 dBm or more
Output impedance	50 ohms		
Signal purity	Harmonic distortion ≤20 dBc (at maximum output, 40 MHz to 3.8 GHz) Non-harmonic spurious ≤25 dBc (at maximum output, 40 MHz to 3.8 GHz) Phase noise -85 dBc to 20 log (f/40 MHz) 10 kHz offset, 1 Hz bandwidth, at maximum output		
Sweep function	Frequency, signal level		
Sweep parameter	Frequency, signal level		
Maximum sweep range	40 MHz to 8.0 GHz		
Frequency	<b>Type A</b>	<b>Type B</b>	<b>Type C</b>
	+17 dBm to -8 dBm	+7 dBm to -18 dBm	+10 dBm to -15 dBm
Signal level	Linear/log frequency sweep, partial and arbitrary frequency sweep, level sweep and CW (single frequency) sweep		
	Sweep type		
Sweep time	0.15 ms/point (with normalized calibration) 0.25 ms/point (with 2-port full calibration) The minimum sweep time differs according to measurement format, type of error correction, sweep width per point, number of measurement points and IF bandwidth.		
Measurement point	3, 6, 11, 21, 51, 101, 201, 301, 401, 601, 801, or 1201 points		
Sweep trigger	Either "Continuous, hold, single sweep" or "External trigger" can be selected.		
Sweep mode	Dual Sweep Sweeps 2 channels (CH 1 and CH 2) with the same frequency range. Alternate sweep Sweeps 2 channels (CH 1 and CH 2) with different sweep types and frequency ranges.		

#### Test port Characteristics

Test port	25°C ±5°C	
Load matching	18 dB	40 MHz to 2.6 GHz
	16 dB	2.6 GHz to 3.8 GHz
	14 dB	3.8 GHz to 8.0 GHz
Directivity	25°C ±5°C	
	30 dB	40 MHz to 2.6 GHz
	26 dB	2.6 GHz to 3.8 GHz
Crosstalk	Types A and B	
	Type C	
	90 dB (40 MHz to 3.8 GHz)	90 dB (40 MHz to 2.6 GHz)
	80 dB (3.8 GHz to 5.0 GHz)	85 dB (2.6 GHz to 3.8 GHz)
	70 dB (5.0 GHz to 8.0 GHz)	70 dB (3.8 MHz to 5.8 GHz)
Connector	Type N (f), 50 ohms	
Noise level	With respect to -20 dB below maximum input level of test board	
	-90 dB	3 kHz bandwidth
	-100 dB	10 kHz bandwidth
Maximum input level	Types A and B	
	Type C	
	0 dBm	+15 dBm (40 MHz to 3.8 GHz) +12 dB (3.8 GHz to 8 GHz)
Input burning level	+21 dBm, ±30 VDC	
Maximum port bias	±30 VDC, 0.5 A (type C only)	

#### Error Correction Function

Normalized	Corrects frequency response (amplitude and phase) at transmission and reflection measurement.
1-port calibration	Corrects errors due to directivity, frequency response and source matching at reflection measurement. (For error correction, short/open/load calibration tools are required.)
2-port calibration	Corrects errors due to directivity, frequency response, source matching, load matching, and isolation at transmission and reflection measurement. (Type C only)
Data averaging	Averages data (vector value) for each sweep. Average factor can be set to 2 to 999.
Data smoothing	Obtains moving average between adjacent measurement points.
Electrical length correction	Adds measured phase and group delay time and equivalent electrical length or delay time.
Phase offset correction	Adds measured phase and a constant phase offset.
Correction by frequency interpolation	In frequency interpolation mode calibration, calculates error coefficient even when frequency and number of horizontal axis points are changed. Changes in frequency range (start/stop) are applied for the frequency range at initial calibration.

#### Connection of External Equipment

External display signal	15 pin D-SUB connector (VGA)
GPiB data output & remote control	Conforms to IEEE488.
Parallel I/O	TTL level, 8 bit output (2 ports) 4 bit input and output (2 ports)
Serial I/O	Conforms to RS232.
Keyboard I/O	Conforms to IBM PC-AT.
External reference frequency input	Input frequency range : 1, 2, 5, and 10 MHz ±10 ppm 0 dBm (50 ohms) or less
Probe power	±15 V ±0.5 V, 300mA

#### Display Unit

R3766H series	Fluorescent character display tube, green
Display unit	256 × 64 dots
Resolution	Character display, 32 lines × 8 characters
Display mode	
R3767H series	7.8 inch TFT color LCD
Display unit	640 × 480 dots
Resolution	Log/linear Cartesian coordinate, polar coordinate and Smith chart (impedance/admittance display)
Display mode	Single channel 2 channels (Overlapped display, separated display) 4 channels (Separated display)
Display format	
Measurement condition display	Start/stop, center/span, scale/DIV reference level, marker value, soft key functions, warning messages
Reference line position	Top (100%) to bottom (0%) of vertical-axis memory
Auto scale	Sets reference value and scale so that measured trace be displayed in the best form.
Brightness	Backlight can be turned ON or OFF.

#### Marker Function (R3767H only)

Marker display	Marker reading can be converted into display value corresponding to each measurement format.
Multi marker	10 markers can be set independently for each channel.
Delta marker	Each of 10 delta markers can be specified as reference marker and delta value between markers can be measured.
Marker couple	Markers of each channel can be set in coupled or independent manner.
Analysis of specified section	Marker search for section specified with Δ marker can be performed.
MRK search	MAX search, MIN search, and NEXT search
Marker tracking	Search operation for each sweep.
Target search	Calculates bandwidth, center frequency and Q for -X dB point. Frequency for phase 0° and frequency width of ±X° can be searched for.
MRK →	MRK → reference value, MRK → START, MRK → STOP, MRK → CENTER
Limit line function	

#### Programming Function

BASIC controller function	The R3766H/3767H series and any other measuring instruments with GPiB interface can be controlled by means of standard controller function.
Built-in functions	High-speed analysis of measurement data is possible using built-in functions.
FDD function	Conforms to MS-DOS format Accommodates 3 modes (DD 720 kB, HD 1.2 MB/1.4 MB)

#### General Specifications

Operating environment	When FDD is used	Temperature range : +5 to +40°C Humidity range : 80% or less (without condensation)
	When FDD is not used	Temperature range : 0 to +50°C Humidity range : 80% or less (without condensation)
Storage environment	Storage temperature range : -20 to +60°C	
Power voltage	100 to 120 VAC, 220 to 240 VAC, 48 to 66 Hz Automatic switching between 100 VAC and 200 VAC lines	
Power consumption	300 VA or less	
Dimensions	Approx. 424 (width) × 220 (height) × 400 (depth) mm	
Weight	16 kg maximum (R3767H series)	